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U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

ATTORNEY DOCKET NO.
1793.1083
FIRST NAMED INVENTOR

Sheet 1 of 1 APPLICATION NO. 10/765,277

LIST OF REFERENCES CITED BY APPLICANT

(Use several sheets if necessary)

Han-Kook CHOI et al

FILING DATE

GROUP ART UNIT

January 28, 2004

2055 2627

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
	AA	4,617,655	10/14/86	Aldenhoven			
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FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	TRANSLATION YES NO	ABSTRACT
DD	AG	10-144031	05/29/98	Japan		Х
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)						
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.) **TRANSLATION** YES NO Office Action issued in Chinese Patent Application No. 200410069242.2 AM Χ DD on May 19, 2006.

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